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| Search Notes | Application/Control No. | Applicant(s)/Patent Under Reexamination |
| | 10717632 | VERBINSKI ET AL. |
|  | Examiner | Art Unit |
| | Lee, Shun | 2884 |

SEARCHED

| Class | Subclass | Date | Examiner |
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| 250 | 358.1 | 6/28/2007 | /SL/ |
| 250 | 336.08 | 6/28/2007 | /SL/ |
| 250 | 359.1 | 6/28/2007 | /SL/ |
| 250 | 360.1 | 6/28/2007 | /SL/ |
| 378 | 57 | 6/28/2007 | /SL/ |
| 378 | 198 | 6/28/2007 | /SL/ |

SEARCH NOTES

| Search Notes | Date | Examiner |
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| EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, IBM_TDB) - See Search History Printout | 6/28/2007 | /SL/ |

INTERFERENCE SEARCH

| Class | Subclass | Date | Examiner |
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